

Notice of References Cited	Application/Control No. 10/619,994	Applicant(s)/Patent Under Reexamination LIN ET AL.
	Examiner Anabel M Ton	Art Unit 2875

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	B	US-6,773,145	08-2004	Yang, Pu-Ming	362/352
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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